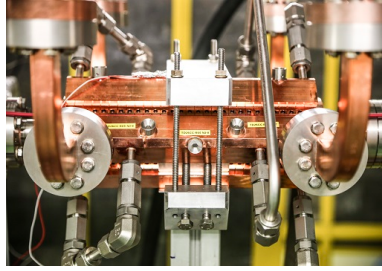


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**Test stands for breakdown studies on beam-driven
and RF-driven structures - Jay Hirshfield (Yale
University and Omega-P R&D, Inc)**

Tuesday, 13 June 2017 15:50 (25 minutes)

Presenter: HIRSHFIELD, Jay L (Yale University & Omega-P, Inc.)